

FORM HDP-1449 (Based on Form PTO-1449)		ATTORNEY DOCKET NO.	SERIAL NO.
		8375-000006/DVA	10/652,138
		APPLICANT	
		Koichiro Tanaka	
		FILING DATE	GROUP
		August 29, 2003	1614

PATENT AND TRADEMARK OFFICE
INFORMATION DISCLOSURE CITATION
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Sheet 1 of 1

U.S. PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.						

FOREIGN PATENT DOCUMENTS

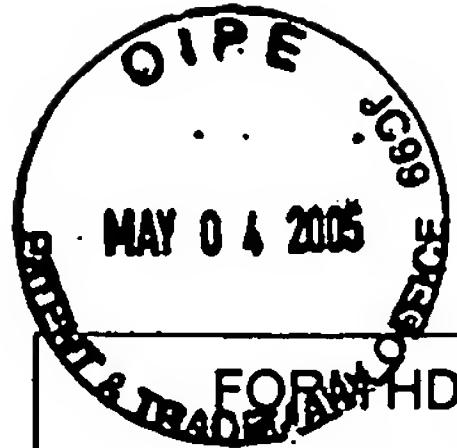
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes	No
1.	Z.F	63-22013	1/29/1988	Japan			X

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)

Ref. Desig.	Examiner's Initials	
1.	Z.F	Tsuchisaka, Yoshiyuki, "New Ophthalmology", 1987, Vol. 4, No. 6, pp. 755-759.
2.	Z.F	Masuda et al, Kanjiro, "Report on Clinical Medicine in Ophthalmology", 1985, Vol. 79, No. 7, pp. 1410-1422.
3.	Z.F	Communication from Japanese Patent Office re: related application (with translation).

Examiner: *Zahn Fag* Date Considered: 8/30/06

EXAMINER: Please initial if citation considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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1.	Z.F	8-231435	9/10/1996	Japan			X
2.		10-158171	6/16/1998	Japan			X
3.		10-226641	8/25/1998	Japan			X
4.		10-67687	3/10/1998	Japan			X
5.		63-22013	1/29/1988	Japan			X
6.		2001-329002	11/27/2001	Japan			X
7.		WO 00/37124	6/29/2000	PCT		N/A	
8.	Z.F	WO 98/34655	8/13/1998	PCT		N/A	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

Ref. Desig.	Examiner's Initials	
1.		Communication from Japanese Patent Office re: counterpart application (with translation).

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Zahn Fay

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